Microfabrication and Evaluation of a Silicon Microelectrode Based on SOI Wafer*

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Abstract: An implantable seven-channel silicon microelectrode was fabricated by MEMS (micro-electro-mechanical system) micromachining techniques for optic-nerve visual prosthesis applications. Theoretical analyses of noise contributed to determining the size of the exposed recording sites of the microprobe. The geometry configuration was optimized for the silicon microprobe to have enough strength and flexibility and to reduce the insertion-induced tissue trauma. Impedance test results showed that the average value of the channels was $2.3M\Omega$ at 1kHz when applied with a stimulating voltage with the amplitude of 50 mVpp which is suitable for neural signal recordings. *In-vivo* animal experiment showed that the recorded neural signal amplitude from the primary visual cortex was $8\mu\text{V}$.

Key words: MEMS; visual prosthesis; silicon microelectrode; in-vivo experiment

PACC: 0670D; 0710C; 7340 EEACC: 2110; 2550; 2575B

1 Introduction

Implantable microprobes or microelectrodes are key components for epiretinal^[1,2], subretinal^[3,4], suprachoroidal^[5], visual cortical^[6,7] and optic-nerve^[8,9] visual prosthesis applications. At present, various scientific research groups contribute to these different kinds of visual prostheses and have produced some preliminary results for clinical applications. For opticnerve visual restoration, microelectrodes are applied to stimulate optic nerves to restore vision for retinitis pigmentosa (RP) and age-related macular degeneration (AMD) patients. To realize the fundamental corresponding relationships between optic-nerve bundles and the primary visual cortex for pattern sensation, stimulation and recording microelectrodes are used for optic-nerve stimulation and cortical neural recording, respectively. Due to the millions of axons in the optic-nerve, rigid requirements are put forward for the optic-nerve stimulation and cortical recording microelectrodes.

Considerations for the implantable microelectrodes can be made from several aspects such as biocompatibility, tissue trauma, uniformity, and high yield. Metal microwires and silicon microelectrodes are usually selected as the neural interface for neural recording and stimulation. Metal microwires made of stainless steel, tungsten, and platinum were prevalent at the early stage of neural prosthesis applications. They were manufactured manually and had poor uniformity, low yield, and high cost. With the development of the micro-electro-mechanical system (MEMS) micromachining technique, silicon-based microelectrodes can be fabricated in batches and have satisfactory uniformity, high yield, and low cost. The silicon microelectrodes have relatively good flexibility and mechanical strength compared with silicon/silicon dioxide ones^[10,11]. Si (silicon), SiO₂ (silicon dioxide), and Si₃N₄(silicon nitride) are biocompatible with biological tissue and suitable for *in-vivo* application^[12]. As a result, silicon-based microelectrodes have attracted much interest in recent years. Two and three-dimensional Michigan and Utah silicon microelectrodes have been fabricated $[13\sim16]$. The silicon microelectrodes or microprobes can be fabricated based on singlecrystal silicon or silicon-on-insulator (SOI) wafers. Based on single-crystal silicon substrate, a deep p⁺⁺ boron diffusion process is usually included to determine the outline of the silicon microelectrodes with higher concentration grads between the p⁺⁺ layer and the silicon substrate. This presents rigid requirements for the diffusion process. In contrast, based on an SOI wafer, the top silicon or silicon device layer determines the thickness of the silicon microelectrode with precisely controlled uniformity. Moreover, the buried

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SiO₂ layer is an etch stop layer while releasing the microelectrode. The fork-like microprobe based on SOI substrates was demonstrated by the double-sided deep reactive ion etching (DRIE) processing technique[17,18]. Double-sided photolithography and an additional mask for the base plate were introduced to obtain thin-film needle-shaped microprobes with a bonding pad area as thick as the original SOI wafer. The thicker base plate increased the weight and vertical dimension of the microprobes, and tissue dimpling may not be reduced effectively. In addition, the exposed recording sites were concave and not close enough to the neuron body or axon, which affected the neural recordings efficiency. Consequently, there is still room for the improvement of previous processes or designs.

Research on silicon-based microprobes from other groups mainly concentrates on the details of the fabrication process. By contrast, our work theoretically analyzes the noise to optimize the dimension of the stimulating sites, and a silicon microelectrode was fabricated based on SOI substrate with a uniform thickness of $15\mu m$. The base plate was as thick as the probe shaft determined by the top silicon layer of the SOI wafer. The double-sided photolithography and one mask for the base plate were eliminated, and resulted in less tissue dimpling. A seven-channel silicon microprobe was fabricated for visual cortical recordings. The site size was optimized according to theoretical analysis results of thermal noise, and the impedance was on the order of $M\Omega$ at 1kHz. The outline design required that the silicon microprobe had a sharp side with a small lateral tip angle to reduce the insertioninduced tissue trauma. Processes and designs of the silicon microprobe based on SOI wafer were detailed in this paper. In-vivo animal experiment results showed that the microelectrode was feasible to record visual cortical neural signals for optic-nerve visual prosthesis applications.

2 Design and fabrication methodology

2. 1 Noise analyses

The *in-vivo* neural recording setup is unavoidably affected by main-frequency disturbance, background noise, and thermal (Johnson) noise of the microelectrode. Disturbance from the main frequency can be eliminated by a shielded cover. The background noise results from respiration and excitation of thousands of neurons far from the exposed microelectrode sites and is closely related to the animal conditions, and so the

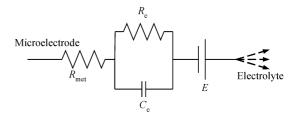


Fig. 1 Equivalent circuit of microelectrode-electrolyte interface

thermal noise analysis is detailed here. After the microelectrode was implanted in vivo, the exposed metal sites were electrically related with physiological saline solution. The equivalent circuit of the metal-electrolyte interface was illustrated in Fig. 1. $R_{\rm met}$ denoted the interconnecting metal wire resistance on the order of tens of ohms, and $C_{\rm e}$ and $R_{\rm e}$ denote the double-layer capacitance and resistance, respectively. E is the half-cell voltage at the metal-electrolyte interface.

According to Fig. 1, thermal noise was dominated by $R_{\rm met}$, $R_{\rm c}$ - $C_{\rm c}$ network. $R_{\rm met}$ and the resulting power spectral density (PSD) of thermal noise were shown in Eqs. (1) and (2), respectively.

$$R_{\text{met}} = \rho \times \frac{L}{S} \tag{1}$$

$$S(f) = 4kTR_{\text{met}} \tag{2}$$

where k (= 1.38 × 10⁻²³ J/K) was the Boltzmann's constant, T was the absolute temperature in Kelvin, ρ is the gold resistivity with the value of $2.4 \times 10^{-8} \Omega \cdot m$, L was the connecting wire length of several millimeters, and S denoted the cross section area. In our design, L was selected as 6mm, S was 300nm × 5 μ m, and R_{met} was 96 Ω . According to Eq. (2), $S(f) = 1.6 \times 10^{-18} \text{ V}^2/\text{Hz}$, and the equivalent thermal noise voltage was 1.3nVrms, which is neglected usually. Therefore, the noise is mainly produced from the R_e - C_e network shown in Fig. 2.

Figure 2 (a) showed the practical parallel network of a resistor and capacitor, and Figure 2 (b) shows the equivalent noise model of this network considering thermal noise from $R_{\rm e}$. The dashed-line block denotes the ideal network. The PSD of $R_{\rm e}$ and the transfer function h(f) were, respectively, expressed in Eqs. (3) and (4), the PSD of the output terminals $S_{\rm out}(f) = S_{\rm v}(f) |h(f)|^2$ was shown in Eq. (5), and the

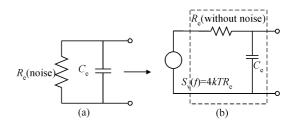


Fig. 2 Noise-analysis model of R_e - C_e network

total noise $P_{n,out}$ within the total frequency range was shown in Eq. (6).

$$S_{\rm v}(f) = 4kTR_{\rm e} \tag{3}$$

$$h(f) = \frac{1}{1 + i2\pi f R_c C_c} \tag{4}$$

$$h(f) = \frac{1}{1 + j2\pi f R_e C_e}$$

$$S_{\text{out}}(f) = \frac{4kTR_e}{1 + 4\pi^2 R_e^2 C_e^2 f^2}$$
(5)

$$P_{\text{n.out}} = \int_0^\infty S_{\text{out}}(f) \, \mathrm{d}f = \frac{kT}{C_e}$$
 (6)

where the unit of kT/C_e was V^2 , and $(kT/C_e)^{1/2}$ was the equivalent noise voltage with the unit of Vrms. The equivalent noise voltage of the R_e - C_e network within the total frequency range was inversely proportional to $C_{\rm e}$. With settled temperature, increasing $C_{\rm e}$ reduced the thermal noise voltage, which increased the site area for the multichannel microelectrode with planar metal sites exposed. At a body temperature of 310K, the equivalent thermal noise voltage at the total frequency range was 65. $4\mu Vrms$ with a C_e of 1pF.

Thermal noise analyses resulted in the size selection of the exposed planar site, and the impedance Z was mainly determined from R_e and C_e in Eq. (7).

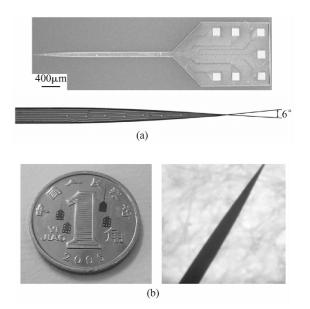
$$Z = \frac{R_{\rm e}}{1 + j2\pi f R_{\rm e} C_{\rm e}} \tag{7}$$

In view of Eqs. (6) and (7), low thermal noise meaned a large signal-to-noise ratio (SNR), a large site size, low impedance, and low spatial resolution.

To achieve high spatial resolution, microelectrodes for neural spike recording had a site size comparable to the neuron body, which introduced large impedance on the order of $M\Omega$ with relatively large noise voltage. The site size must be compromised to satisfy the requirements of low thermal noise (high sensitivity) and high spatial resolution (high selectivity).

2. 2 Fabrication process technology

Compared with the Si/SiO₂ microelectrode based on silicon substrate, the silicon one was fabricated on SOI substrate. The original SOI wafer was manufactured by a bonding technique with a top silicon layer of $15\mu m$, a buried silicon dioxide layer of $1\mu m$, and a silicon base plate of $500\mu m$. The fabrication process was as follows: (1) Lower 300nm silicon nitride layer was deposited on the SOI wafer by plasma enhanced chemical vapor deposition (PECVD)[9] to electrically separate the top silicon of the SOI wafer and metal connecting wires. (2) Lower titanium/gold (Ti/Au) of 100nm/300nm was sputtered on the lower silicon dioxide successively and patterned as conductor traces by diluted buffered oxide etching (BOE) and gold corrosive, respectively. Then, the probe was annealed at 380°C for 40min. (3) Upper 300nm SiO₂ was deposited by PECVD to insulate the metal layer from the



Silicon microelectrode based on SOI wafer (a) SEM picture of the microelectrode top view after ICP process The probe shank was 3mm long with a 6° tip angle, and the exposed seven circle recording sites were 10μm in diameter; (b) Picture of released individual silicon microelectrodes with the top and back sides shown: the tip was sharp and arc-shaped

tissue solution. (4) The upper SiO₂ layer was etched by BOE to open Φ -6 μ m contact holes near the tip and bond pads at the rear. (5) According to step (2), seven Φ -10 μ m circular recording sites were formed with the central space of 120 µm. (6) A thick photoresist was used as the mask layer, and the horizontal architecture of the microelectrode was determined by the ICP (inductively-coupled plasma) dry etching process technique. (7) The wafer was thinned to 200 µm by physical ablation of the bottom silicon and adhered to plane glass plate by black wax. Then the wafer was further thinned to 50μ m by BOE solution. (8) After removing the wax, the top side of the wafer was protected and adhered to another silicon wafer by a photoresist. The bottom silicon layer of the wafer was plasma dry etched using SF₆. Because of the low selectivity ratio between silicon and silicon dioxide, the buried silicon dioxide layer was removed at the same time. Consequently, the individual silicon microelectrodes were accomplished after the photoresist-removing techniques by acetone.

Figure 3 showed the pictures of the silicon microelectrode.

3 **Evaluation and discussion**

3.1 Noise and impedance characteristics

To increase the spatial resolution, the size of the recording sites should be as small as possible. Small

Table 1 Tested capacitance C_e of the seven-channel microelectrode

Recording site 1/pF	Recording site 2/pF	Recording site 3/pF	Recording site 4/pF
60	69	58	64
Recording	Recording	Recording	Average
site 5/pF	site 6/pF	site 7/pF	/pF
60	69	58	62.5

Table 2 Tested impedances of the seven-channel microelectrode

Recording	Recording	Recording	Recording
site $1/M\Omega$	site $2/M\Omega$	site $3/M\Omega$	site $4/M\Omega$
2.5	1.49	2.65	2.3
Recording	Recording	Recording	Average
site $5/M\Omega$	$site 6/M\Omega$	site $7/M\Omega$	/ MΩ
2.5	1.49	2.65	2.3

site area meaned large noise voltage and large impedance. To compromise the noise voltage and spatial resolution, the site size was optimized as $10\mu m$ in diameter, comparable to a neural cell body. According to Eq. (6), the thermal noise voltage was proportional to the square root of $C_{\rm e}$. In our experiment, $C_{\rm e}$ was tested in 0.9% saline solution in a stainless cup by a IMP-1 LCR Meter (BAK ELECTRONICS, Inc.).

With the temperature of 310K and $C_{\rm e}$ of 62.5pF, the resulting thermal noise voltage was 2.61 μ Vrms. This value was much smaller than the neural signals on the order of tens to hundreds of μ V. In order to further reduce the noise, some measures could be adopted to rough the site surface without changing the dimension.

Impedance had a direct relationship with site area and the spatial resolution. As a result, impedance evaluation became a common method to non-invasively determine the electrical continuity and conditions of chronically implanted microelectrodes *in-vivo*. Since electrophysiological saline solution was the primary constituent of body fluids, it was generally assumed as the impedance-testing environment *in-vivo*.

The impedance Z was tested under the same conditions as $C_{\rm c}$. Two terminals of the impedance spectrometer were connected to one channel of the silicon-based microelectrode and the stainless cup, respectively. The channel impedances at 1kHz were displayed in Table 1, and the results showed that the impedance was on the order of $M\Omega$ with an applied voltage amplitude of $50 \, {\rm mVpp}$. The average impedance value was $2.3 \, {\rm M}\Omega$, which was ideal for neural recordings.

3. 2 In-vivo experiment

Rabbits were selected as the experiment animals, and proper animal surgery was adopted to expose the optic nerve and the primary visual cortex. The rabbits

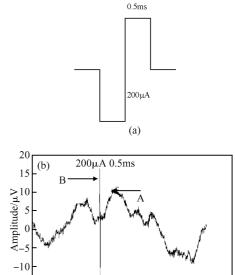


Fig. 4 (a) Stimulating microcurrent pulse; (b) EEP signal from primary visual cortex recorded by the silicon microprobe

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were anesthetized with intravenous injection of 3% pentobarbital sodium (30mg/kg). After the skin of external canthus was dissected, conjunctiva and sub-Tenon space was opened at the limbus under a surgical microscope. The lateral rectus muscle was found and then snipped. Microsurgical forceps were used to expose the optic nerve near the eyeball. The contralateral visual cortex pia was also exposed.

Although the platiridium microelectrode was manually made with unsatisfactory uniformity and low yield, it was selected to stimulate the optic nerve in our work because of its favorable mechanical strength, stable electrochemical characteristics, and good biocompatibility.

Two Φ -85 μ m platiridium microwires were inserted to the optic nerve bundles and formed the stimulation circuit loop. The silicon microelectrode was implanted to the primary visual cortex to record neural signals with the reference electrode on the skull. Then, when stimulating microcurrent was applied to the platiridium microwires, the corresponding electrical evoked potential (EEP) signals could be picked up by the multichannel silicon microelectrode. Figure 4 shows the relationship between stimulating and recording signals. The stimulating microcurrent waveform between two microwires is shown in Fig. 4 (a), and the resulting signal recorded by silicon microelectrode is shown in Fig. 4 (b).

Signals A and B in Fig. 4 (b) were the recorded EEP and wake signal, respectively, and the former was about $8\mu V$ in amplitude. The response region of the visual cortex was small considering the size of the stimulating microwires. As a result, when the silicon

microelectrode was a little far from the response region, the EEP amplitude was relatively low. In order to effectively localize the response region, a silicon microelectrode array with more shanks and channels will be used.

4 Conclusion

Multichannel silicon microelectrodes were fabricated based on SOI wafers for optic-nerve visual prosthesis. Owing to the sandwich structure, the top silicon layer was used as the main body and determined the thickness of the microelectrode. According to the theoretical analyses of thermal noise, the site size was decided for recording purposes, and so was the impedance. The details of the fabrication process were described and pictures of the fabricated silicon microelectrodes were shown. With a lateral tip angle of 6° and a sword-shaped outline, the induced tissue trauma can be reduced greatly. The bonding pad area was as thick as the probe shank, which can reduce the tissue dimpling and aids in chronic neural recordings. The Φ -10 μ m circular recording sites protrude to form a close relationship with the outside electrolyte or neurons. The acute in-vivo animal experiment showed that the silicon microelectrode was feasible for neural recordings.

To further determine the preliminary relationship between optic nerve and primary visual cortex for optic nerve visual restoration, a 3D silicon microelectrode array with more channels and probe shanks will be fabricated.

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基于 SOI 硅片的硅微电极制作与评估*

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摘要:采用微机电系统(MEMS)工艺方法制作了基于 SOI 衬底的七通道硅微电极,用于视神经视觉修复.通过噪声分析确定了硅微电极的金属暴露位点的几何尺寸.优化设计了硅微电极的几何结构,以便于减小植入损伤.阻抗测试结果表明,当测试电压为 50 mVpp时,1 kHz频率下,微电极的单通道阻抗为 $2.3 \text{M}\Omega$,适用于神经电信号记录.在体实验结果表明,动物初级视皮层记录到的神经电信号幅度为 $8 \mu \text{V}$.

关键词: MEMS; 视觉修复; 硅微电极; 在体试验

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